Session 8 Presentation 2

#### TestConX 2020

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- As better performance devices with higher memory bandwidth emerge in the automotive and the mobile industries, the demands for higher test speeds increase.
- Demands on high-speed, extremely small and dense packages have been steadily increasing in the semiconductor market.
- Due to the increasing data rate of the devices, the industries who provide the testing technology face more difficult challenges to meet the requirement.
- Signal/Power integrity issues increase : Crosstalk, Jitter, Skew, Inter-symbol Interference (ISI), PDN (power delivery network), Eye-diagram.
  - → Needs High Performance Test Solution for analyzing IC Packages.















	Spring	Rubber	3D MEMS	*AHCS
Figure				
Pros.	<ul> <li>Height ≤ 6.0mm</li> <li>Stoke (controllable)</li> <li>Force (controllable)</li> </ul>	<ul> <li>Concept (simple)</li> <li>Less ball damage</li> <li>Delivery</li> <li>Cost</li> </ul>	<ul> <li>Fine pitch (coaxial)</li> <li>Position accuracy</li> <li>High pin counts</li> <li>Size (max. 300mm wafer)</li> </ul>	<ul> <li>High pin counts</li> <li>Price (reasonable)</li> <li>Less ball damage</li> </ul>
Cons.	<ul> <li>Complicated (coaxial)</li> <li>Fine pitch (coaxial)</li> <li>Cost (coaxial)</li> </ul>	<ul> <li>Fine pitch (Coaxial)</li> </ul>	<ul><li>Cost</li><li>Delivery</li><li>Stroke</li></ul>	<ul> <li>Fine pitch (Coaxial)</li> </ul>

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![](_page_12_Figure_3.jpeg)

![](_page_13_Figure_3.jpeg)

![](_page_14_Figure_3.jpeg)

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#### **Characterizations**

Verification of the Advanced Hybrid Coaxial Socket

![](_page_15_Picture_5.jpeg)

Fig. Measurement system

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- Vector network analyzer (VNA, E5245A@Keysight)
- 1.85mm connector tested to 67GHz using test vehicles
- · Measurement data with de-embedding fixture
- Analysis of frequency domain (S-parameter)
- Analysis of time domain (eye-diagram)

![](_page_15_Picture_12.jpeg)

Fig. 1.85mm connector (67GHz) for test vehicle

➔ The measurement environment for experiment. The universal connectors used for measuring test vehicle.

Design and Analysis of Advanced Hybrid Coaxial Socket for High Bandwidth Package Test

![](_page_15_Picture_16.jpeg)

![](_page_16_Figure_3.jpeg)

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![](_page_17_Figure_3.jpeg)

• Time-Domain Analysis : Eye-diagram at a data rate of 50 Gb/s for advanced hybrid coaxial socket

![](_page_17_Figure_5.jpeg)

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![](_page_18_Figure_3.jpeg)

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![](_page_19_Figure_3.jpeg)

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![](_page_20_Picture_3.jpeg)

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